## Search Notes



	App	licatio	n/Con	trol No.
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10588939

Examiner

Johnson, Ryan J

# Applicant(s)/Patent Under Reexamination

PINEDA DE GYVEZ ET AL.

Art Unit

2817

#### **SEARCHED**

Class	Subclass	Date	Examiner
331	14,18,34,44,185,186	12/7/2007	Ryan Johnson
324	537,763,765,771,76.12,76.15,76.53	12/7/2007	Ryan Johnson
327	156,157	12/7/2007	Ryan Johnson

### **SEARCH NOTES**

Search Notes	Date	Examiner
See EAST history	12/7/2007	Ryan Johnson
Emailed Joseph Chang	12/7/2007	Ryan Johnson
IEEE search	12/7/2007	Ryan Johnson

#### **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner

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